

First Results on HPK Sensors from FNAL Beam Test 2023

Christopher Madrid eRD112/LGAD Consortium Meeting June 20, 2023

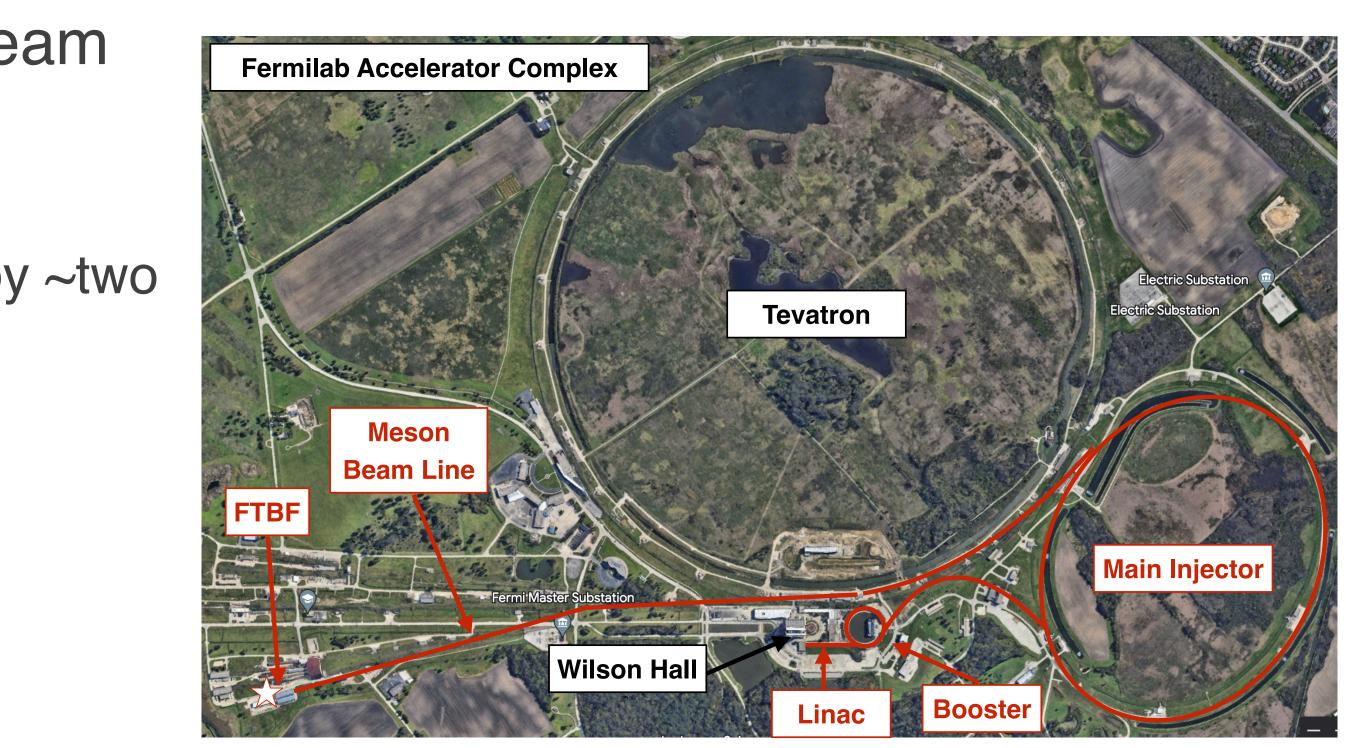
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Overview

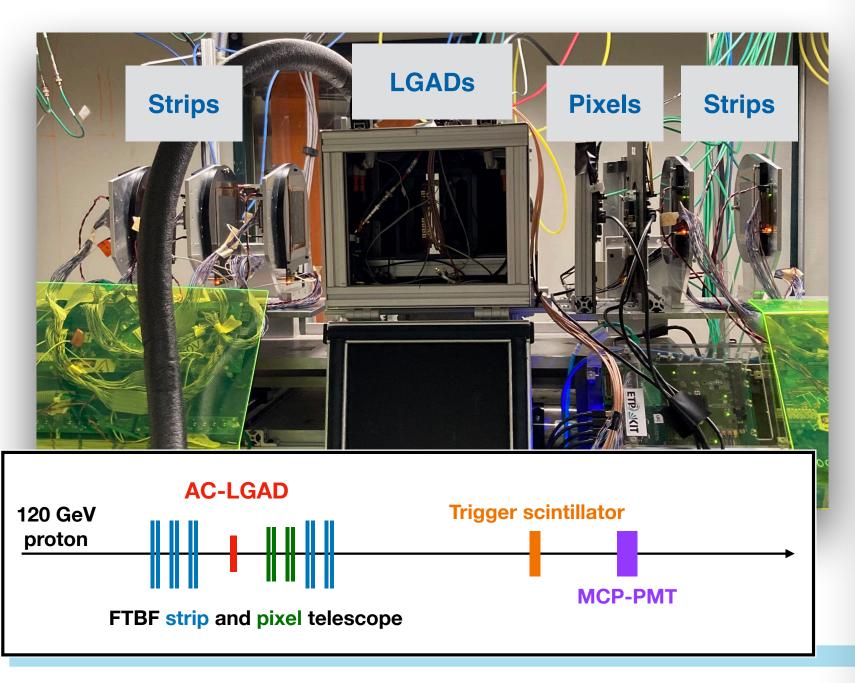
- Recently concluded an AC-LGAD test beam focused on HPK sensors for EIC
 - Lasted about a month
 - Beam outage extended test beam campaign by ~two weeks
- Collected data for both strips and pixels
 - Used 120 GeV protons from Main Injector
 - Used FTBF telescope for track reference
 - Used Photek MCP-PMT for time reference
- Actively analyzing the data but already have some preliminary results





Fermilab 4D-trackers test beam infrastructure

- Permanent setup in FNAL test beam facility (FTBF)
 - Movable: slide in and out of beamline as needed, parasitic use of beam
 - Environmental controls: sensor temperature (-25 C to 20 C), and humidity, monitoring
 - Time reference with ~ 10 ps resolution (MCP)
 - DAQ: high bandwidth, high ADC resolution 8-channel scope
 - Record 20k events during 4 s spill,
 - Tracker with ~5 µm resolution
- Developed readout boards for the characterization of LGADs
 - Without complex ASIC and DAQ





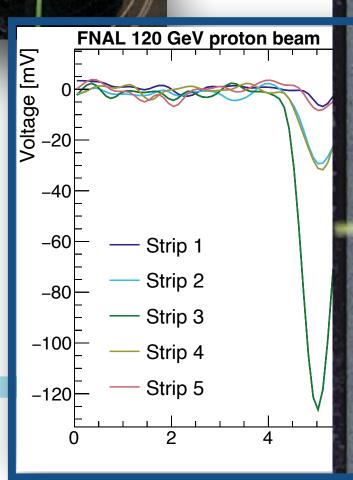
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of beam d humidity, monitoring

> 8-channel oscilloscope 2 GHz, 10 GSa/s



Cold box (5 LGAD slots)

LV, motor stage control, thermal monitoring

NN 🚬

High BW Multiplexer

Scope





Sensors tested

- Tested samples with various parameters
 - Resistivity: C-type and E-type
 - Coupling capacitance: 240 and 600
 - Metal electrode:
 - For strips 50 and 100 microns width
 - For pixels 150² and 300² microns area
 - Active thickness: 20 and 50 microns
 - Strip pitch: 80 and 500 microns
 - Strip length: 5 and 10 mm

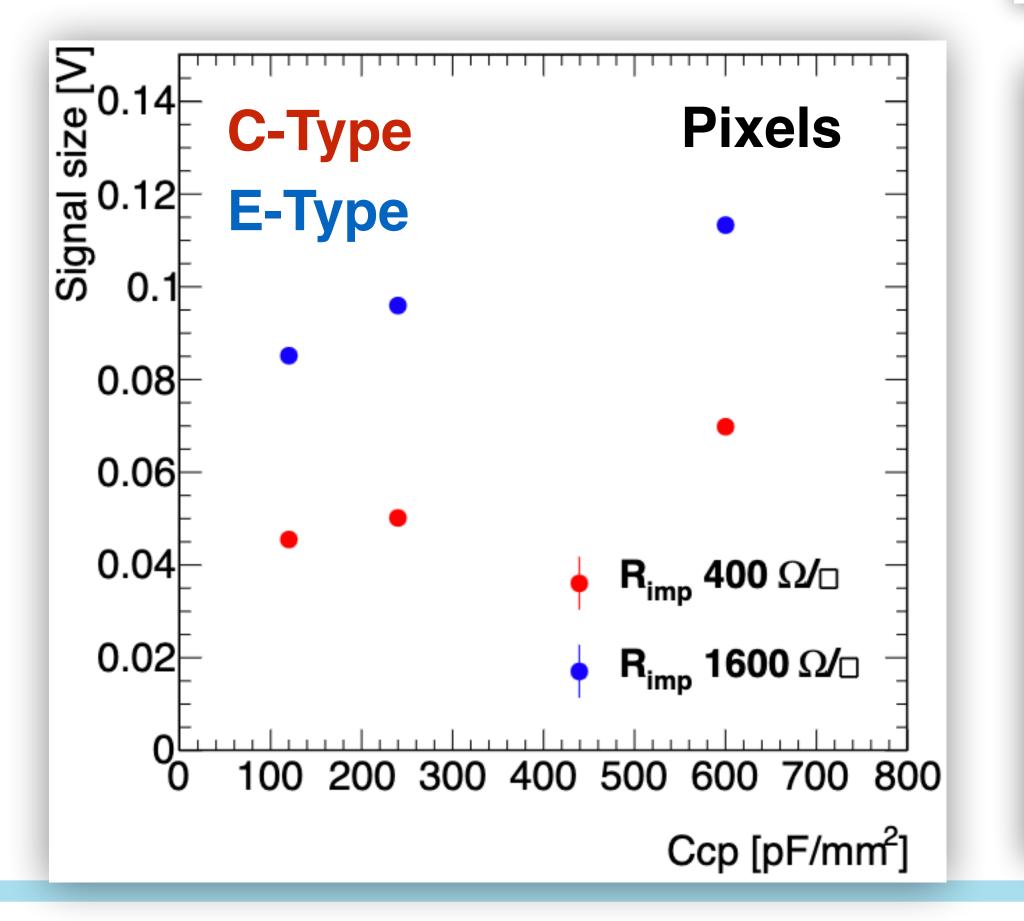
	Wafer_Thickness_Length_Pitch_Metal_Res./Co
	HPK_W8_50T_1P0_500P_100M_C600
	HPK_W8_50T_1P0_500P_50M_C600
	HPK_W4_50T_1P0_500P_50M_C240
	HPK_W5_50T_1P0_500P_50M_E600
	HPK_W9_20T_1P0_500P_50M_E600
	HPK_W2_50T_1P0_500P_50M_E240
	HPK_W9_20T_1P0_500P_100M_E600
	HPK_W9_20T_0P5_500P_50M_E600
Pixels	HPK_W5_50T_500x500_150M_E600
	HPK_W8_50T_500x500_150M_C600
	HPK_W9_20T_500x500_150M_E600
	HPK_W11_20T_500x500_150M_C600
	HPK_W9_20T_500x500_300M_E600
mall Pitch Strips	HPK_50T_1P0_80P_60M_E240
	HPK_20T_1P0_80P_60M_E240





What to expect?

- New paper from beta source measurements: https://arxiv.org/abs/2305.12355
- Higher the resistivity and coupling capacitance \rightarrow higher the signal (at a cost of signal sharing)
- Longer the strips \rightarrow Smaller signals



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Table II. Physical parameters of the produced sensor types; Strip and Pixel. The overall size, electrode pitch, electrode width, and the numbers of electrodes in column and row directions are summarized. "Cut Strip" contains strips of different lengths ($200\mu m \sim 8890\mu m$) in one sensor.

Sensor type	Strip	Cut Strip		Pixel	
overall dimension (mm)	11.2 >	< 2.7	2.4×2.4		
electrode pitch (µm)	80		100×100	150×150	200×200
electrode	40, 45, 60, 70	40, 60	90	140	190
dimension (µm)	×9880	$\times 200 \sim 8890$	×90	$\times 140$	$\times 190$
#column×#row	16×1		10×10	6×6	5×5

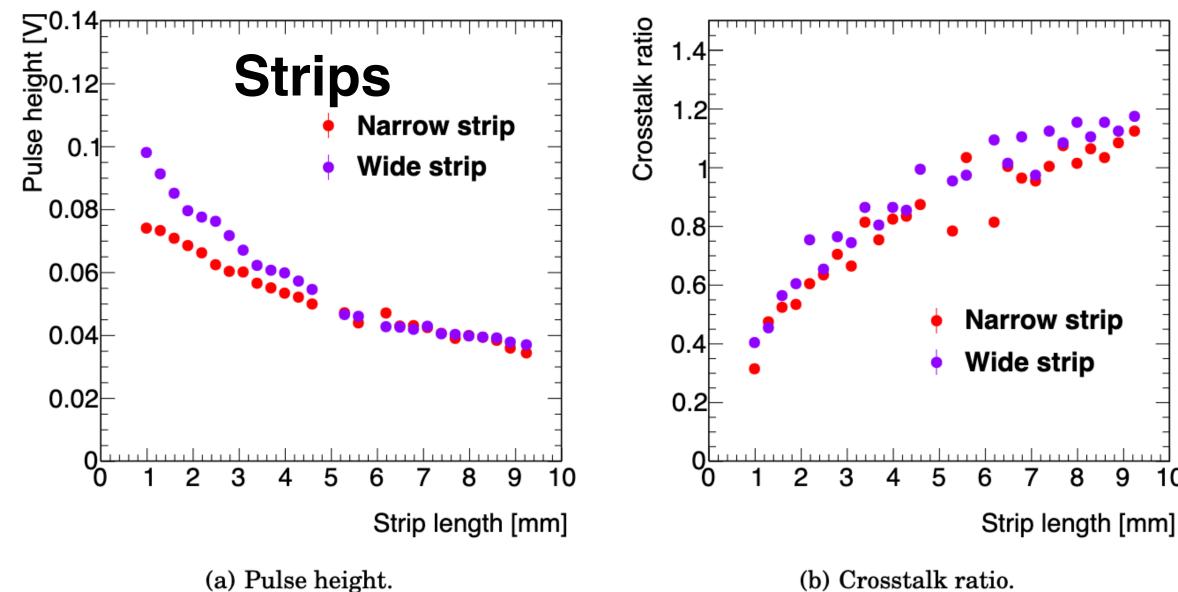
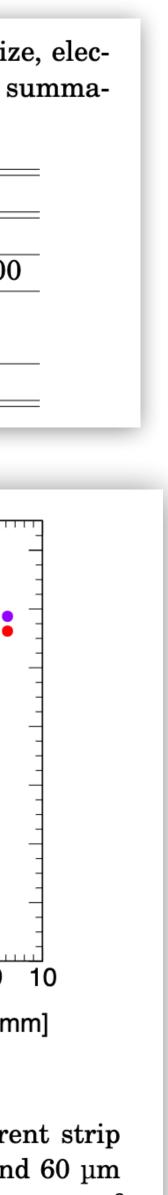


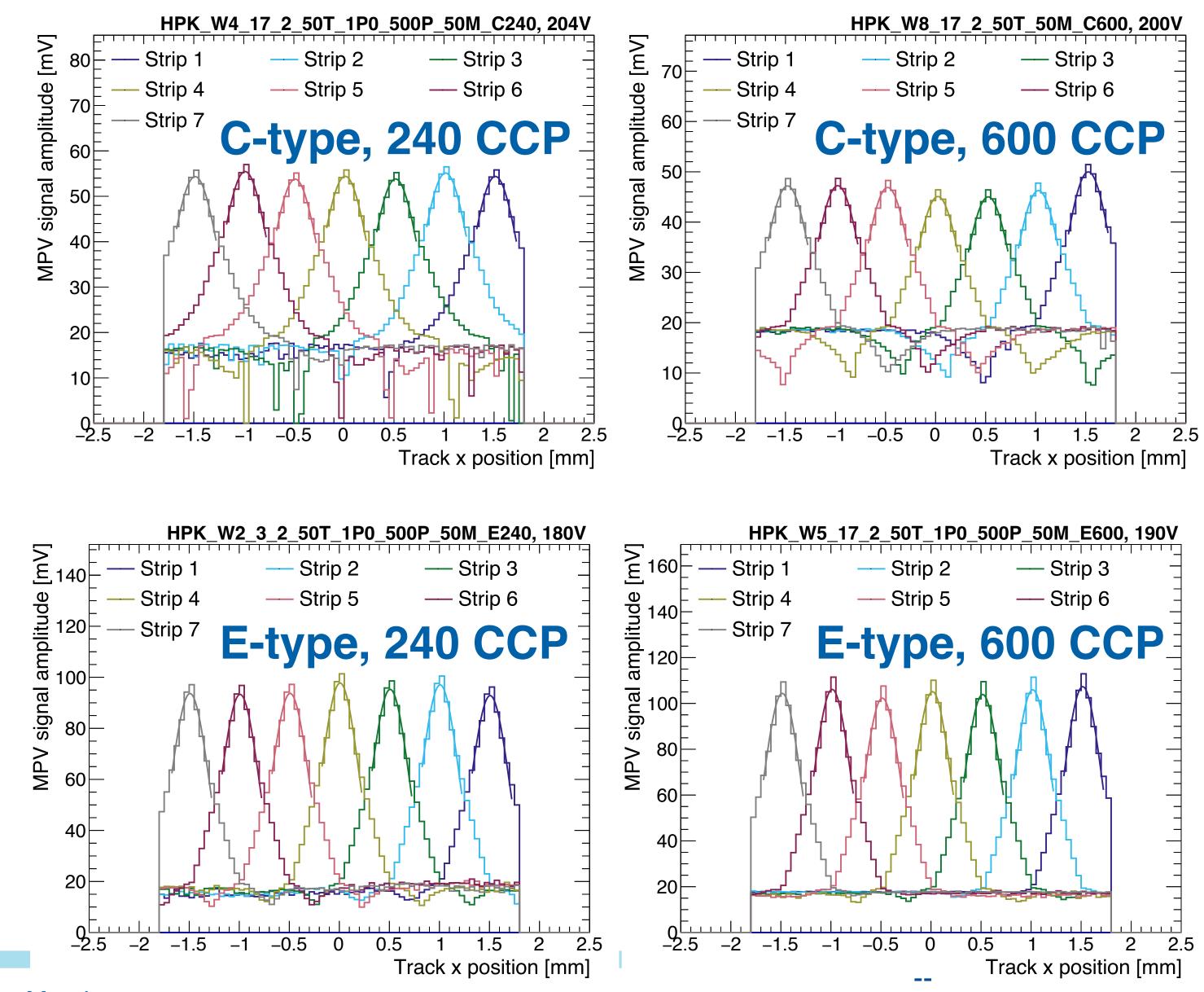
Fig. 5. The pulse height (left) and crosstalk (right) of dedicated strip sensors with different strip lengths which is measured by 90 Sr. Narrow and wide strips are with electrodes of 40 μ m and 60 μ m widths, respectively. The cross-talk ratio is defined as pulse height of leading divided by the sum of neighboring strips.





Resistivity and Capacitance

- From pixel beta source results:
 - Expect C-type signals of 50 70 mV
 - Observe ~50 mV under metal
 - Expect E-type signals of 90 110 mV
 - Observe ~100 mV under metal
- We reproduce beta source results for pixels under strip metal
- Signal drops by 30% or 40% in the gaps for C-type and E-type
- Coupling capacitance does not dominate signal size or sharing
 - Will continue investigating



.mplitude [mV

signal

MPV

signal

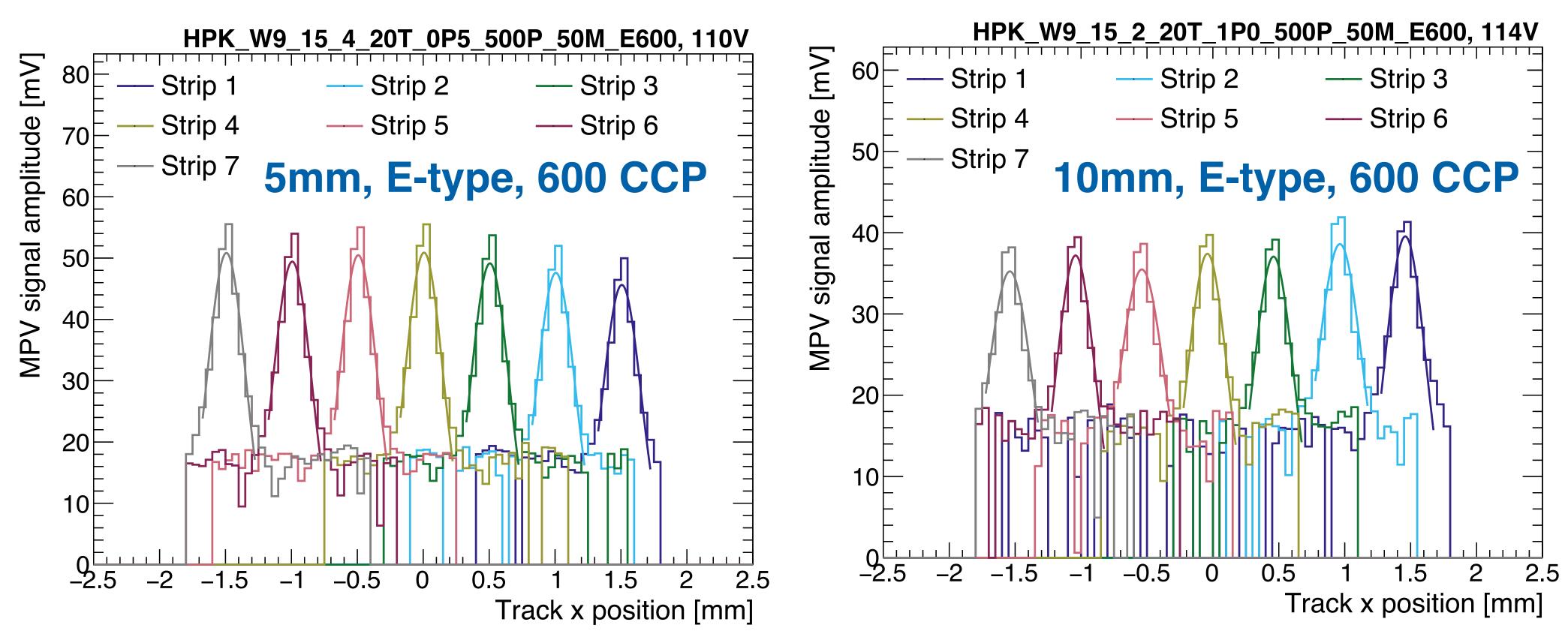
80

40

20

Adw 60

Length Difference

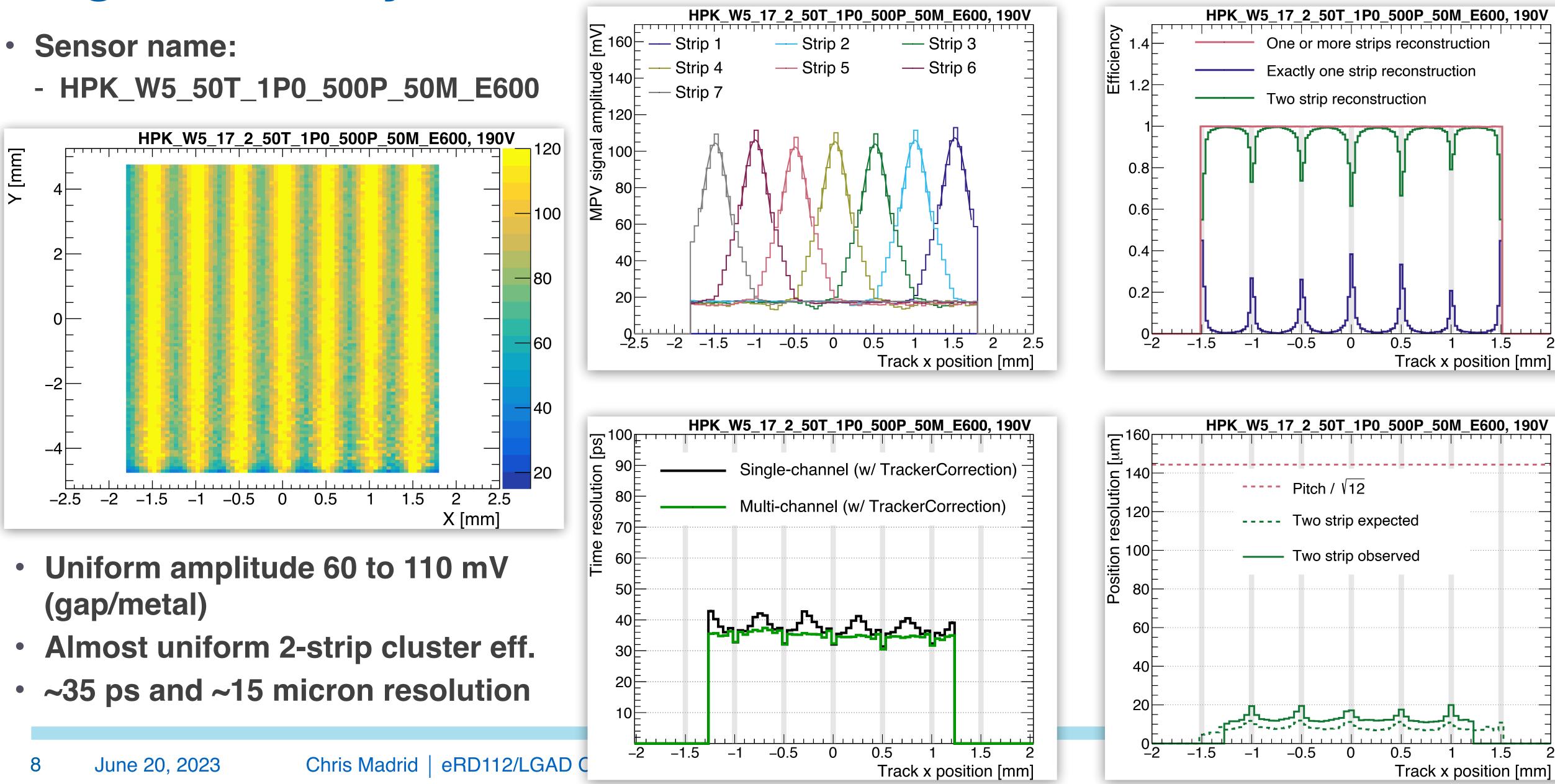


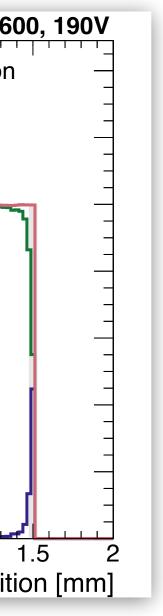
- the metal for 5 vs. 10 mm long strips
- Should expect ~25% drop based on beta source measurements

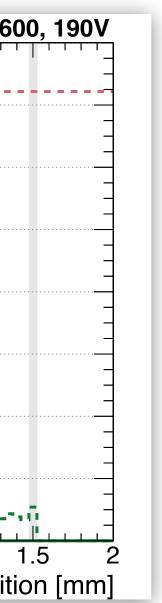
For the 20 micron thick sensor we observe a ~30% drop in signal size under



High resistivity 50 micron thick results







Next steps

- Continue analyzing strip data - Plenty more results and conclusions left to be drawn
- Will begin looking at Pixel data this week
- Contribute results to FY23/FY24 proposal
- Write a summary paper for all AC-LGAD results from this year - BNL and HPK results
- Draw conclusions for next sensor production





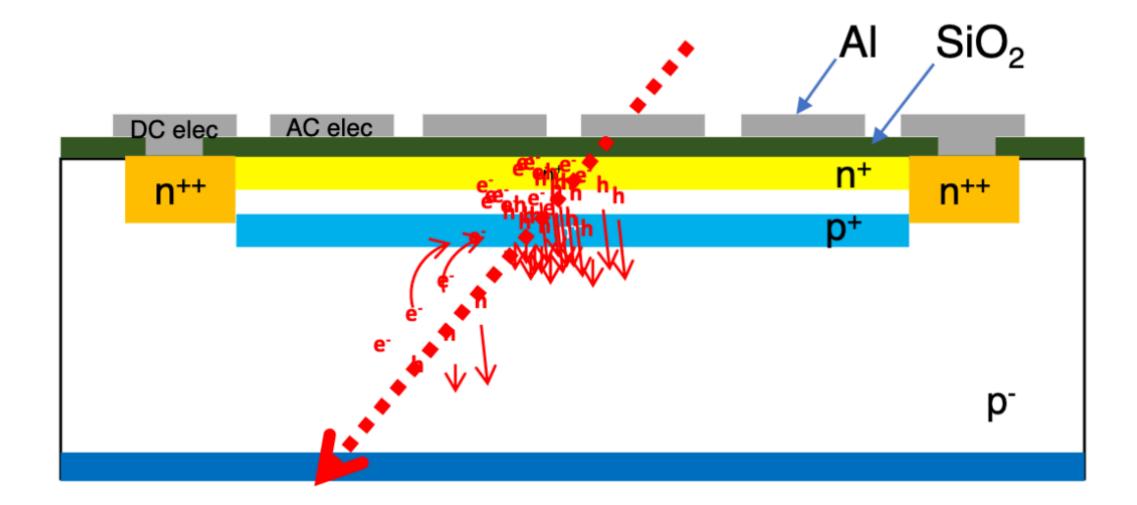
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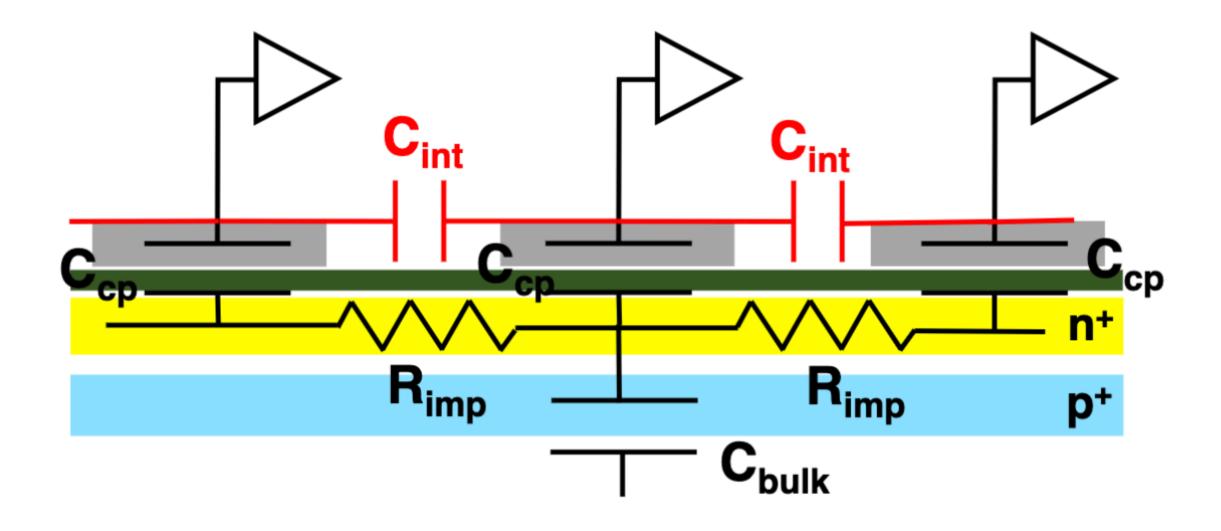
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AC-LGADs Diagrams







Available HPK Long Strip Sensors

Pitch	Resistivity	Thickness	Length	Metal	Cap.
500 μm	E-Type	20 µm	5 mm	50	240 pF/mm ²
			10 mm	50 µm	
		C-Type 50 µm	20 mm	100	600 pF/mm ²
	C-Type		25 mm	100 µm	
80 µm	E-Type	20 µm	10 mm	40 µm	240 pF/mm ²
	C-Type	50 µm	25 mm	60 µm	600 pF/mm ²

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